

# iC-MFN

## 8-FOLD FAIL-SAFE N-FET DRIVER

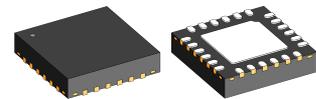
### FEATURES

- ◆ 8-fold level shift up to 40 V output voltage
- ◆ Inputs compatible with TTL and CMOS levels, 40 V voltage proof
- ◆ Level shift configurable to 5 V, 10 V or supply voltage
- ◆ Short-circuit-proof push-pull current sources for driving FETs slowly
- ◆ Safe low output state with single errors
- ◆ Ground and supply voltage monitor
- ◆ Status output for error and system diagnostics
- ◆ Temperature range from -40 to 125 °C
- ◆ Protective ESD circuitry

### APPLICATIONS

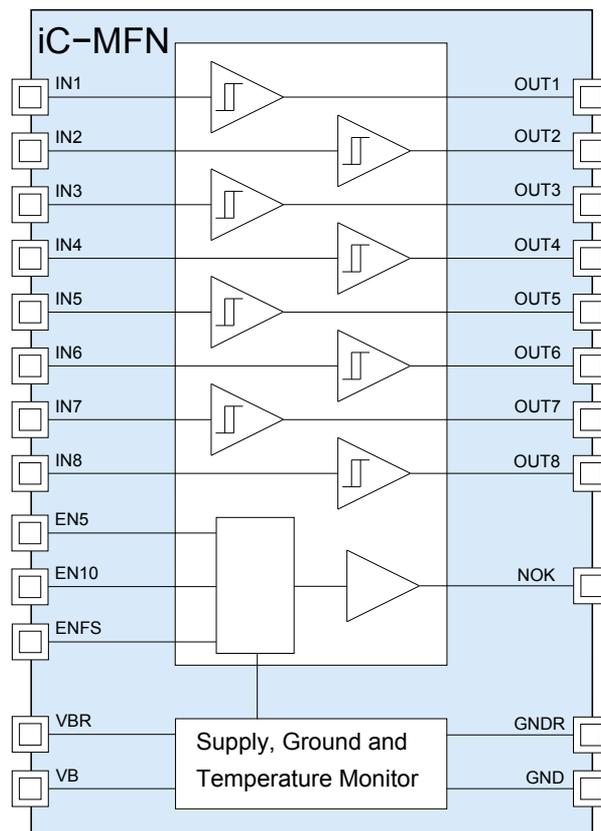
- ◆ Operation of N-FETs from 1.8 V, 2.5 V, 3.3 V or 5 V systems

### PACKAGES



QFN24 4 mm x 4 mm

### BLOCK DIAGRAM



# iC-MFN

## 8-FOLD FAIL-SAFE N-FET DRIVER

### DESCRIPTION

iC-MFN is a monolithically integrated, 8-channel level adjustment device which drives N-channel FETs. The internal circuit blocks have been designed in such a way that with single errors, such as open pins (VB, VBR, GND, GNDR) or the short-circuiting of two outputs, iC-MFN's output stages switch to a predefined, safe low state. Externally connected N-channel FET are thus shut down safely in the event of a single error.

The inputs of the eight channels consist of a Schmitt trigger with a pull-down current source and are compatible with TTL and CMOS levels and are voltage-proof up to 40 V. The eight channels have a current-limited push-pull output stage and a pull-down resistor at the output. The hi-level at one of the inputs EN5, EN10 or ENFS defines the output hi-level and enables the outputs. The output hi-level is disabled with the lo-level at all inputs EN5, EN10 and ENFS or with the hi-level at more than one input.

iC-MFN monitors the supply voltage at VB and VBR pin and the voltages at the two ground pins GND and GNDR. Both power supply pins VB and VBR and both pins GND and GNDR must be connected together externally in order to guarantee the safe low state of the output stages in the event of error.

Should the supply voltage at VB undershoot a predefined threshold, the voltage monitor causes the

outputs to be actively tied to GND via the low side transistors. If the ground potential ceases to be applied to GND, the outputs are tied to GNDR by pull-down resistors.

If the connection between the ground potential and the GND pin is disrupted, the high side and low side transistors of the output stages are shut down and the outputs tied to GNDR via the pull-down resistors. If on the other hand the connection between ground potential and the GNDR pin is disrupted, only the output stage high side transistors are shut down; the outputs are then actively tied to GND via the low side transistors.

Pull-down currents provide the safe lo-level at open inputs IN1...8, EN5, EN10 and ENFS. The pull-down currents have two stages in order to minimize power dissipation with enhanced noise immunity.

The status of the device is indicated with the Open-Drain pin NOK and can be used for system diagnostics.

Temperature monitoring protects the device from too high power dissipation.

The device is protected against destruction by ESD.

# iC-MFN

## 8-FOLD FAIL-SAFE N-FET DRIVER

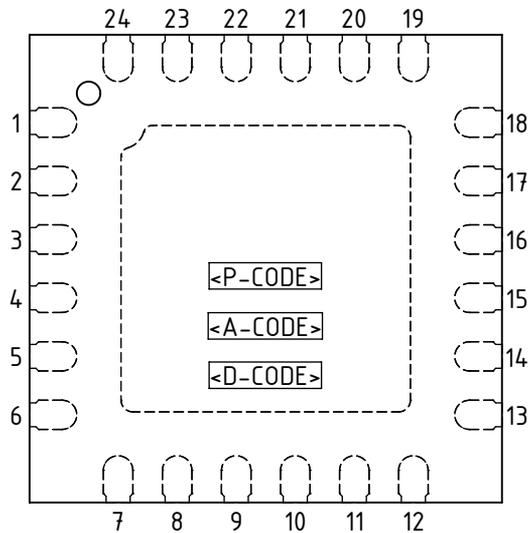
preliminary



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### PACKAGING INFORMATION

#### PIN CONFIGURATION QFN24-4x4 (topview)



#### PIN FUNCTIONS

No.	Name	Function
1	OUT1	Output channel 1
2	VB	Supply Voltage
3	VBR	Supply Voltage (R)
4	EN5	Enable input hi-level = 5V
5	EN10	Enable input hi-level = 10V
6	IN1	Input channel 1
7	IN2	Input channel 2
8	IN3	Input channel 3
9	IN4	Input channel 4
10	IN5	Input channel 5
11	IN6	Input channel 6
12	IN7	Input channel 7
13	IN8	Input channel 8
14	NOK	Output inverted status
15	ENFS	Enable input full scale hi-level = VB
16	GNDR	Ground (R)
17	GND	Ground
18	OUT8	Output channel 8
19	OUT7	Output channel 7
20	OUT6	Output channel 6
21	OUT5	Output channel 5
22	OUT4	Output channel 4
23	OUT3	Output channel 3
24	OUT2	Output channel 2
	TP	Backside Paddle

IC top marking: <P-CODE> = product code, <A-CODE> = assembly code (subject to changes), <D-CODE> = date code (subject to changes);

The Backside Paddle is to be connected to a ground plane on the PCB. Connections between GND, GNDR and the ground plane should be considered with system FMEA aspects.

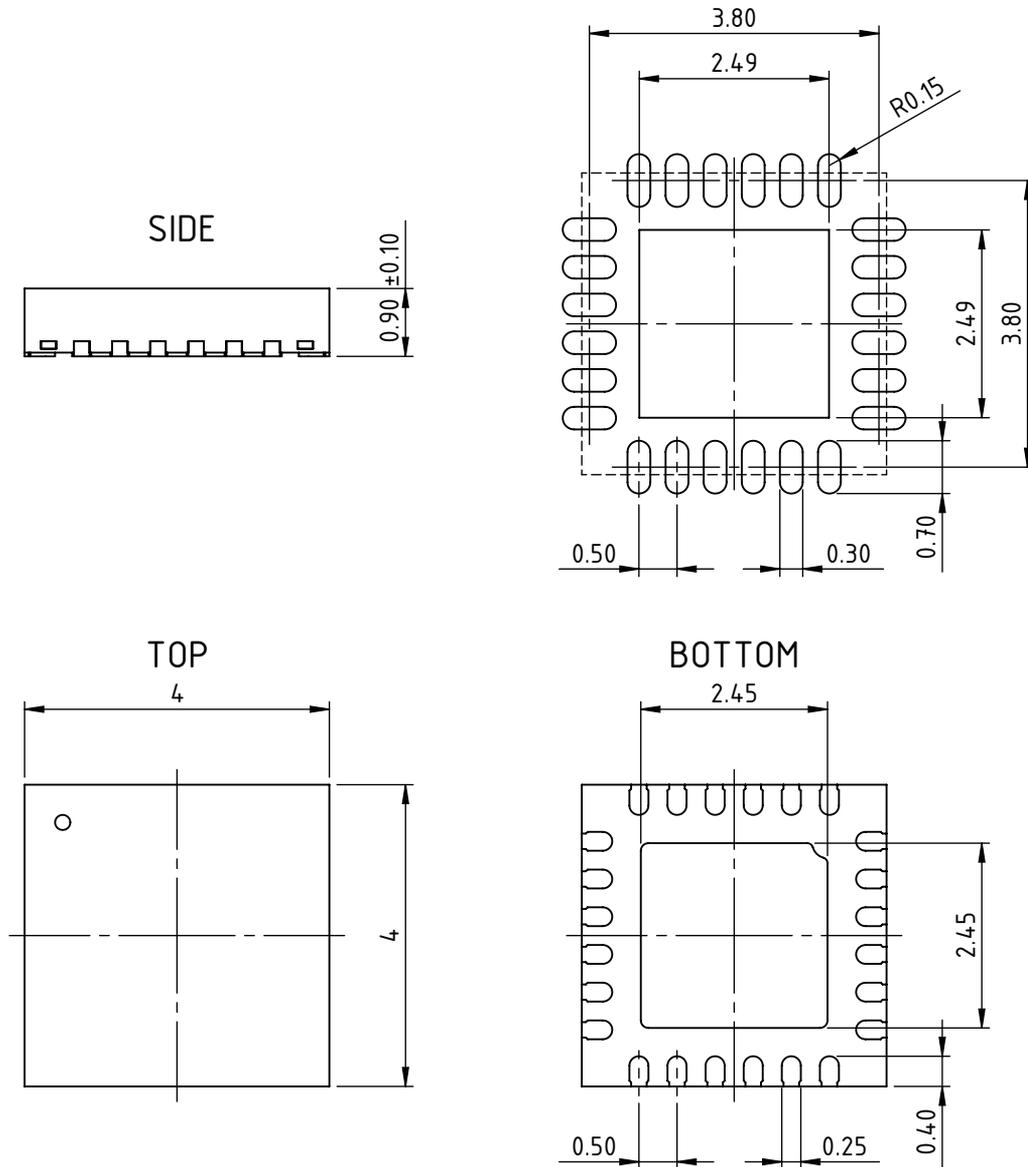
# iC-MFN

## 8-FOLD FAIL-SAFE N-FET DRIVER

### PACKAGE DIMENSIONS

All dimensions given in mm.

### RECOMMENDED PCB-FOOTPRINT



All dimensions given in mm.  
Tolerances of form and position according to JEDEC MO-220.

# iC-MFN

## 8-FOLD FAIL-SAFE N-FET DRIVER



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### ABSOLUTE MAXIMUM RATINGS

Beyond these values damage may occur; device operation is not guaranteed.

Item No.	Symbol	Parameter	Conditions	Limits		Unit
				Min.	Max.	
G001	VB, VBR	Supply Voltage		-0.3	40	V
G002	V()	Voltage at OUT1...8, NOK		-0.3	40	V
G003	V()	Voltage at IN1...8, EN5, EN10, ENFS		-0.3	40	V
G004	V(GNDR)	Voltage at GNDR referenced to GND		-0.3	0.3	V
G005	V(GND)	Voltage at GND referenced to GNDR		-0.3	0.3	V
G006	V(VBR)	Voltage at VBR referenced to VB		-0.3	0.3	V
G007	V(VB)	Voltage at VB referenced to VBR		-0.3	0.3	V
G008	Imx()	Current in OUT1...8, NOK, IN1...8, EN5, EN10, ENFS		-10	10	mA
G009	Imx()	Current in VB, VBR		-10	80	mA
G010	Imx()	Current in GND, GNDR		-80	10	mA
G011	Vd()	ESD susceptibility at all pins	HBM 100 pF discharged through 1.5 kΩ		2	kV
G012	Tj	Operating Junction Temperature		-40	140	°C
G013	Ts	Storage Temperature Range		-55	125	°C

### THERMAL DATA

Operating Conditions: VB = VBR = 4.5...40 V, GND = GNDR = 0 V

Item No.	Symbol	Parameter	Conditions	Limits			Unit
				Min.	Typ.	Max.	
T01	Ta	Operating Ambient Temperature Range		-40		125	°C
T02	Rthja	Thermal Resistance Chip/Ambient	SMD assembly, no additional cooling areas.			75	K/W

All voltages are referenced to ground unless otherwise stated.

All currents flowing into the device pins are positive; all currents flowing out of the device pins are negative.

### ELECTRICAL CHARACTERISTICS

Operating Conditions:  $V_B = V_{BR} = 4.5 \dots 40 \text{ V}$ ,  $GND = GNDR = 0 \text{ V}$ ,  $T_j = -40 \dots 125 \text{ }^\circ\text{C}$  unless otherwise stated

Item No.	Symbol	Parameter	Conditions	Tj °C	Fig.				Unit	
						Min.	Typ.	Max.		
<b>Total Device</b>										
001	$V_B$	Permissible Supply Voltage				4.5		40		V
002	$I(V_B)$	Supply Current in $V_B$	No load, EN5 = lo, EN10 = lo, ENFS = lo			1.2		3.6		mA
003	$I(V_B)$	Supply Current in $V_B$	No load, EN5 = hi, EN10 = lo, ENFS = lo, IN1...8 = hi, $V_B = 8 \dots 40 \text{ V}$			3.2		6.6		mA
004	$I(V_B)$	Supply Current in $V_B$	No load, EN5 = lo, EN10 = hi, ENFS = lo, IN1...8 = hi, $V_B = 13 \dots 40 \text{ V}$			3.2		6.8		mA
005	$I(V_B)$	Supply Current in $V_B$	No load, EN5 = lo, EN10 = lo, ENFS = hi, IN1...8 = hi, $V_B = 4.5 \dots 40 \text{ V}$			1.3		6.6		mA
006	$I(V_{BR})$	Supply Current in $V_{BR}$						7		mA
007	$I(GND)$	Current in GND	No load			-7				mA
008	$I(GNDR)$	Current in GNDR	No load, all OUTx = hi			-7				mA
<b>Current Driver OUT1...8</b>										
103	$V_s(OUTx)_{hi}$	Saturation Voltage hi referenced to $V_B$	$V_s( )_{hi} = V_B - V( )$ , INx = hi, ENFS = hi; I() = -0.5 mA I() = -2 mA					0.2 0.8		V V
104	$V_s(OUTx)_{lo}$	Saturation Voltage lo referenced to GND	I() = 0.5 mA I() = 2 mA					0.2 0.8		V V
105	$V_r(OUTx)$	Output Voltage regulated, no load	EN5 = hi, INx = hi, I() = 0 mA, $V_B > 7 \text{ V}$			4.65	5	5.35		V
106	$V_r(OUTx)$	Output Voltage regulated, no load	EN10 = hi, INx = hi, I() = 0 mA, $V_B > 12 \text{ V}$			9.3	10	10.7		V
107	$R_i(OUTx)$	Output Resistance	EN10 = hi or EN5 = hi, INx = hi, I() = $\pm 2 \text{ mA}$			100		700		$\Omega$
108	$V_i(OUTx)$	Output Voltage	I(OUTx) = 2 $\mu\text{A}$ , GND open					600		mV
109	$I_{pd}(OUTx)$	Pull-Down Current	$V(OUTx) = 1 \text{ V}$ , GND open			30		120		$\mu\text{A}$
110	$R_{pd}(OUTx)$	Pull-Down Resistor at OUTx referenced to GNDR	$V_B, V_{BR}, V(OUTx) = 10 \text{ V}$ , GND open			50		300		k $\Omega$
111	$R_{pd}(OUTx)$	Pull-Down Resistor at OUTx referenced to GNDR	$V_B, V_{BR}, V(OUTx) = 40 \text{ V}$ , GND open			100		600		k $\Omega$
112	$I_{sc}(OUTx)_{lo}$	Short circuit current lo	$V( ) = 0.8 \text{ V} \dots V_B$			2	3.6	10		mA
113	$I_{sc}(OUTx)_{hi}$	Short circuit current hi	$V( ) = 0 \dots V_B - 0.8 \text{ V}$			-10	-3	-2		mA
114	$V_{sh}(OUTx)$	Output Voltage at short circuit of two outputs	EN5 = hi, At two different input signals hi and lo					1		V
115	$V_{sh}(OUTx)$	Output Voltage at short circuit of two outputs	EN10 = hi or ENFS = hi, At two different input signals hi and lo					1.3		V
116	$V_t(OUTx)_{hi}$	Threshold Voltage hi monitoring comparator	$V_t( ) = V_r( ) - V( )$ or $V_t( ) = V_B - V( )$			0.8				V
117	$V_t(OUTx)_{lo}$	Threshold Voltage lo monitoring comparator	$V_t( ) = V_r( ) - V( )$ or $V_t( ) = V_B - V( )$					2.2		V
118	$V_t( )_{hys}$	Hysteresis	$V_t( )_{hys} = V_t( )_{lo} - V_t( )_{hi}$			50		300		mV

### ELECTRICAL CHARACTERISTICS

Operating Conditions:  $V_B = V_{BR} = 4.5 \dots 40 \text{ V}$ ,  $GND = G_{NDR} = 0 \text{ V}$ ,  $T_j = -40 \dots 125 \text{ }^\circ\text{C}$  unless otherwise stated

Item No.	Symbol	Parameter	Conditions	Tj °C	Fig.				Unit	
						Min.	Typ.	Max.		
<b>Input IN1...8, EN5, EN10, ENFS</b>										
203	Vt()hi	Threshold Voltage hi				1.15		1.4	V	
204	Vt()lo	Threshold Voltage lo				0.8		1.05	V	
205	Vt()hys	Input Hysteresis	$Vt()hys = Vt()hi - Vt()lo$			200		400	mV	
206	Ipd1()	Pull-Down Current 1	$0.4 \text{ V} < V() < Vt()hi$		5	75	225	350	µA	
207	Ipd2()	Pull-Down Current 2	$V() > 1.4 \text{ V}$		5	20	45	70	µA	
208	Cin()	Input Capacitance						20	pF	
209	Rpd()	Pull-Down Resistor	$V_B, V_{BR} \text{ open}$			10		150	kΩ	
<b>Supply and Temperature Monitor</b>										
301	VBon	Turn-On Threshold VB				3.8		4.45	V	
302	VBoff	Turn-Off Threshold VB	Decreasing voltage VB			3.4		4.2	V	
303	VBhys	Hysteresis	$VBhys = VBon - VBoff$			200			mV	
304	Toff	Turn-Off Temperature	Increasing temperature			145	160	180	°C	
305	Ton	Turn-On temperature	Decreasing temperature			130	147	170	°C	
306	Thys	Hysteresis	$Thys = Toff - Ton$				13		°C	
<b>Ground Monitor GND, GNDR</b>										
401	Vt()hi	Threshold Voltage hi GND Monitor	Referenced to GNDR					270	mV	
402	Vt()lo	Threshold Voltage lo GND Monitor	Referenced to GNDR			50			mV	
403	Vt()hys	Hysteresis	$Vt()hys = Vt()hi - Vt()lo$			5		100	mV	
404	Vt()hi	Threshold Voltage hi GNDR Monitor	Referenced to GND					270	mV	
405	Vt()lo	Threshold Voltage lo GNDR Monitor	Referenced to GND			50			mV	
406	Vt()hys	Hysteresis	$Vt()hys = Vt()hi - Vt()lo$			5		100	mV	
407	Vc()hi	Clamp Voltage GNDR hi referenced to GND	$I() = 1 \text{ mA}$			0.4		2	V	
408	Vc()lo	Clamp Voltage GNDR lo referenced to GND	$I() = -1 \text{ mA}$			-2		-0.4	V	
<b>Status Output NOK</b>										
503	Ii(NOK)	Leakage Current	$GND < V(NOK) < V_B$			-20		20	µA	
504	Vs(NOK)lo	Saturation Voltage lo referenced to GND	$I() = 0.5 \text{ mA}$ $I() = 2 \text{ mA}$					0.2 0.8	V V	
505	Isc(NOK)lo	Short circuit current lo	$V() = 0.8 \text{ V} \dots V_B$			2	3	10	mA	
<b>Supply Monitor VB, VBR</b>										
601	Vt(VB)hi	Threshold Voltage hi VB Monitor	Referenced to VBR					270	mV	
602	Vt(VB)lo	Threshold Voltage lo VB Monitor	Referenced to VBR			50			mV	
603	Vt(VB)hys	Hysteresis	$Vt()hys = Vt()hi - Vt()lo$			5		100	mV	
604	Vt(VBR)hi	Threshold Voltage hi VBR Monitor	Referenced to VB					270	mV	
605	Vt(VBR)lo	Threshold Voltage lo VBR Monitor	Referenced to VB			50			mV	
606	Vt(VBR)hys	Hysteresis	$Vt()hys = Vt()hi - Vt()lo$			5		100	mV	
607	Vc(VBR)hi	Clamp Voltage hi	$I() = 1 \text{ mA}, Vc() = V(VBR) - V(VB)$			0.4		2	V	
608	Vc(VBR)lo	Clamp Voltage lo	$I() = -1 \text{ mA}, Vc() = V(VBR) - V(VB)$			-2		-0.4	V	

### ELECTRICAL CHARACTERISTICS

Operating Conditions:  $V_B = V_{BR} = 4.5 \dots 40 \text{ V}$ ,  $GND = G_{NDR} = 0 \text{ V}$ ,  $T_j = -40 \dots 125 \text{ }^\circ\text{C}$  unless otherwise stated

Item No.	Symbol	Parameter	Conditions	T <sub>j</sub> °C	Fig.				Unit	
						Min.	Typ.	Max.		
<b>Timing</b>										
901	tp(OUTx)	Propagation delay INx, EN5 → OUTx	{{INx,EN5}lo → hi} → 90%OUTx {{INx,EN5}hi → lo} → 10%OUTx CLoad() = 100 pF		1	0.45		1.1	μs	
902	tp(OUTx)	Propagation delay INx, EN5 → OUTx	{{INx,EN5}lo → hi} → 90%OUTx {{INx,EN5}hi → lo} → 10%OUTx CLoad() = 1 nF		1	1.3		2.4	μs	
903	tp(OUTx)	Propagation delay INx, EN5 → OUTx	{{INx,EN5}lo → hi} → 90%OUTx {{INx,EN5}hi → lo} → 10%OUTx CLoad() = 2 nF		1	2.2		3.7	μs	
904	tp(OUTx)	Propagation delay INx, EN5 → OUTx	{{INx,EN5}lo → hi} → 90%OUTx {{INx,EN5}hi → lo} → 10%OUTx CLoad() = 5 nF		1	5		8.1	μs	
905	tp(OUTx)	Propagation delay INx, EN10 → OUTx	{{INx,EN10}lo → hi} → 90%OUTx {{INx,EN10}hi → lo} → 10%OUTx CLoad() = 100 pF		1	0.7		1.6	μs	
906	tp(OUTx)	Propagation delay INx, EN10 → OUTx	{{INx,EN10}lo → hi} → 90%OUTx {{INx,EN10}hi → lo} → 10%OUTx CLoad() = 1 nF		1	2.3		4.1	μs	
907	tp(OUTx)	Propagation delay INx, EN10 → OUTx	{{INx,EN10}lo → hi} → 90%OUTx {{INx,EN10}hi → lo} → 10%OUTx CLoad() = 2 nF		1	3.9		7.1	μs	
908	tp(OUTx)	Propagation delay INx, EN10 → OUTx	{{INx,EN10}lo → hi} → 90%OUTx {{INx,EN10}hi → lo} → 10%OUTx CLoad() = 5 nF		1	9		16	μs	
909	tp(OUTx)	Propagation delay INx, ENFS → OUTx	{{INx,ENFS}lo → hi} → 90%OUTx {{INx,ENFS}hi → lo} → 10%OUTx CLoad() = 100 pF		1	1.4		3.1	μs	
910	tp(OUTx)	Propagation delay INx, ENFS → OUTx	{{INx,ENFS}lo → hi} → 90%OUTx {{INx,ENFS}hi → lo} → 10%OUTx CLoad() = 1 nF		1	5.2		9.8	μs	
911	tp(OUTx)	Propagation delay INx, ENFS → OUTx	{{INx,ENFS}lo → hi} → 90%OUTx {{INx,ENFS}hi → lo} → 10%OUTx CLoad() = 2 nF		1	9.2		16.7	μs	
912	tp(OUTx)	Propagation delay INx, ENFS → OUTx	{{INx,ENFS}lo → hi} → 90%OUTx {{INx,ENFS}hi → lo} → 10%OUTx CLoad() = 5 nF		1	20		35	μs	
913	dV()/dt	Slew rate	$V_B = 24 \text{ V}$ , CLoad() = 100 pF			7		18	V/μs	
914	dV()/dt	Slew rate	$V_B = 24 \text{ V}$ , CLoad() = 1 nF			2.2		4.5	V/μs	
915	dV()/dt	Slew rate	$V_B = 24 \text{ V}$ , CLoad() = 2 nF			1.2		2.5	V/μs	
916	dV()/dt	Slew rate	$V_B = 24 \text{ V}$ , CLoad() = 5 nF			0.5		1.2	V/μs	

### ELECTRICAL CHARACTERISTICS: Diagrams

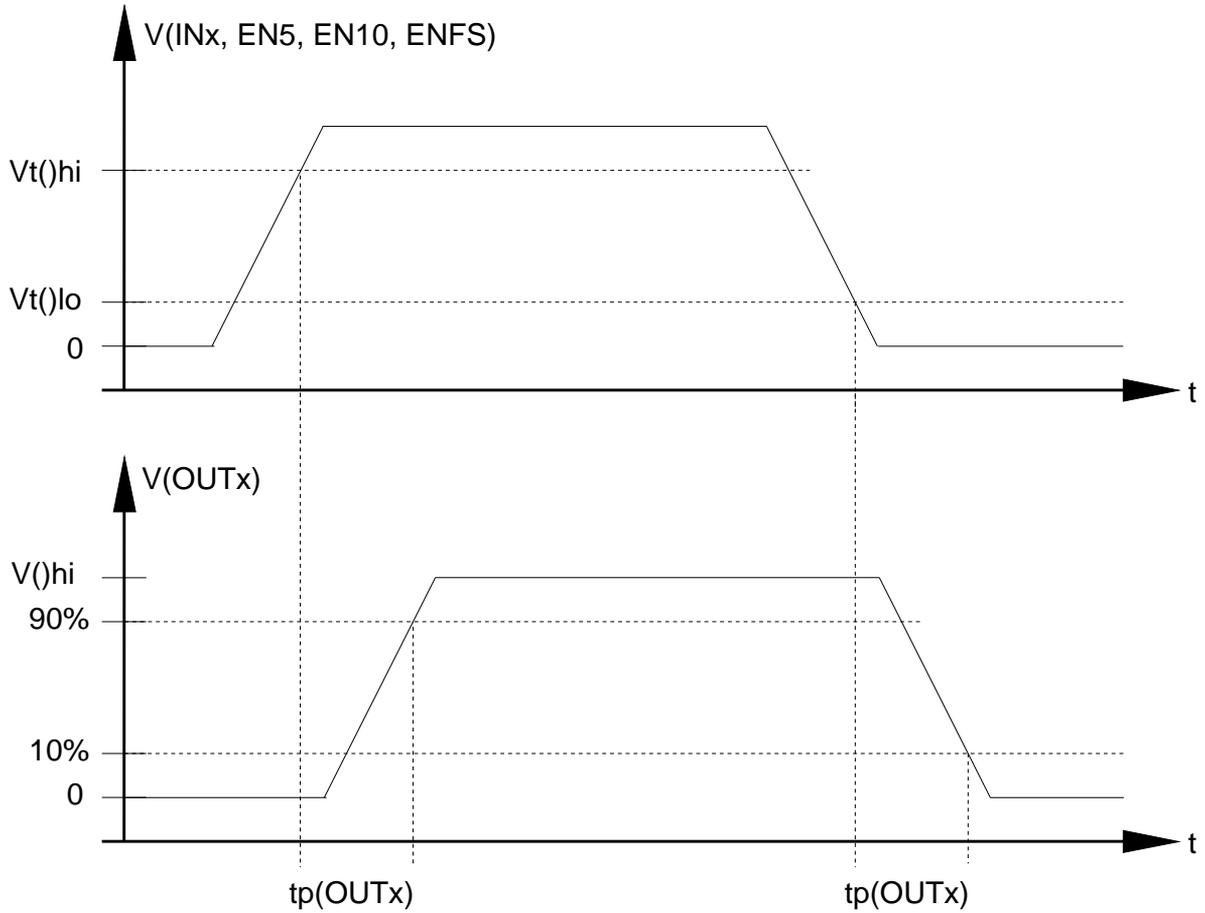


Figure 1: Propagation delays

### DESCRIPTION OF FUNCTIONS

#### Hi-level output configuration

The device iC-MFN has three adjustable hi-levels for driving N-channel FETs. The configured hi-level is common to all outputs OUTx and the maximum level is the power supply VB potential. The hi-level configuration inputs are used simultaneous for enabling the hi-level at the outputs OUTx. The hi-level at exactly one input EN5, EN10 or ENFS configure the voltage of hi-level and enable the outputs. If more than one of these inputs have hi-level the outputs remains disabled. The hi-level 5 V (configured with EN5 = hi) and 10 V (configured with EN10 = hi) are internally generated by a voltage reference and regulated. The hi-level VB (configured with ENFS = hi) is an unregulated connection to VB. In this case the voltage swing depends directly from the power supply VB.

#### Output characteristics of the high side transistor

The high side output transistors at the eight channels demonstrate a resistive behavior with low voltage ( $V_B - V(\text{OUT}_x)$ ) and behave as a current source with finite output resistance with higher voltages.

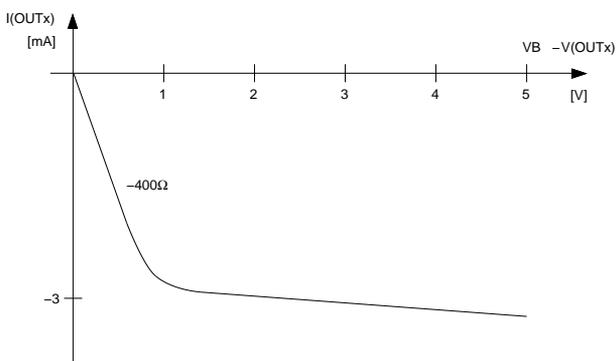


Figure 2: Output characteristic of the high side transistor at OUTx

#### Output characteristic of the regulated push-pull-output at OUTx

The hi-level 5 V and 10 V is generated with a regulated push-pull output and demonstrate a resistive behavior with low voltage changes and behave as a current source with finite output resistance with higher voltage changes.

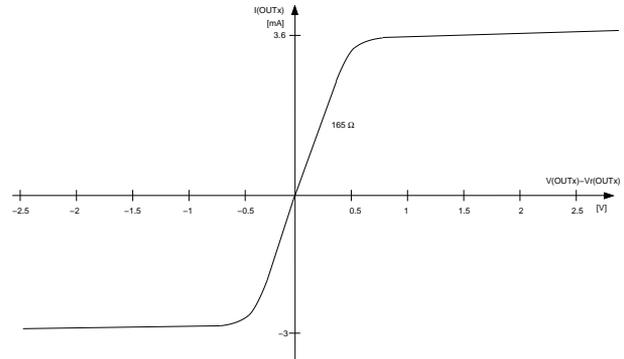


Figure 3: Output characteristic of the regulated push-pull-output at OUTx

#### Output characteristic of the low side transistor

The low side output transistors at the eight channels demonstrate a resistive behavior with low voltage  $V(\text{OUT}_x)$  and behave as a current sink with finite output resistance with higher voltages.

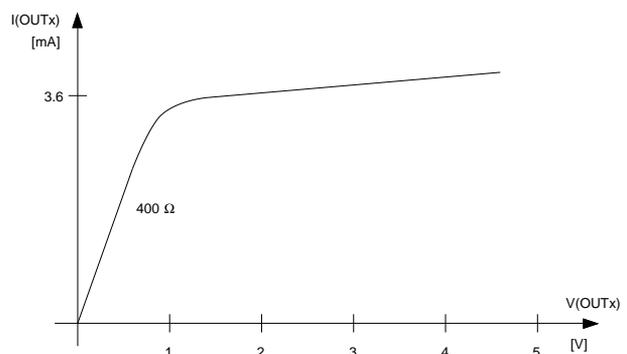


Figure 4: Output characteristic of the low side transistor at OUTx

#### Status output NOK

The status output NOK is a current limited 40 V proof open-drain output. The output transistor is switched on if the hi-level of the outputs OUTx are enabled with exactly one pin ENx, the outputs have reached the voltage levels defined by the inputs INx, the power supply voltage is above the power-on threshold, the temperature is below the switch off temperature and all power supply pins are connected.

# iC-MFN

## 8-FOLD FAIL-SAFE N-FET DRIVER

### Pull-down currents

In order to enhance noise immunity with limited power dissipation at inputs INx, EN5, EN10 and ENFS the pull-down currents at these pins have two stages. With a rise in voltage at input pins INx, EN5, EN10 and ENFS the pull-down current remains high until  $V_t()_{hi}$  (Electrical Characteristics No. 203); above this threshold the device switches to a lower pull-down current. If the voltage falls below  $V_t()_{lo}$  (Electrical Characteristics No. 204), the device switches back to a higher pull-down current.

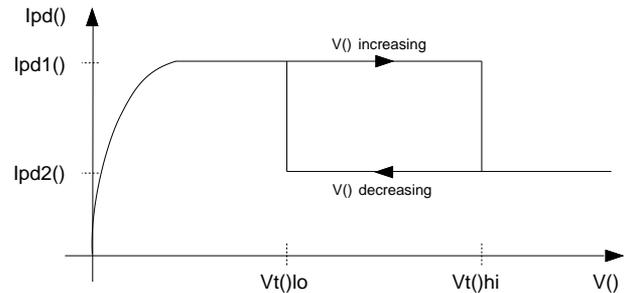


Figure 5: Pull-down currents at INx, EN5, EN10 and ENFS

## DETECTING SINGLE ERRORS

If single errors are detected, safety-relevant applications require externally connected switching transistors to be specifically shut down. Single errors can occur when a pin is open (due to a disconnected bonding wire or a bad solder connection, for example) or when two pins are short-circuited.

When two output of different logic levels are short-circuited, the driving capability of the low side driver will predominate, keeping the connected N-channel FETs in a safe shutdown state.

With open pins VB, VBR, GND or GNDR iC-MFN switches the output stages to a safe, predefined low state via pull-down resistors and current sources at the outputs, subsequently shutting down any externally connected N-channel FETs.

### Loss of VB potential

If power supply potential is no longer applied to the VB-pin, the output stage high side drivers are shut down and the outputs actively tied to GND via the low side drivers.

### Loss of VBR potential

If power supply potential is no longer applied to the VBR-pin, the output stage high side drivers are shut down and the outputs actively tied to GND via the low side drivers.

### Loss of GNDR potential

If ground potential is no longer applied to the GNDR-pin, the output stage high side drivers are shut down and the outputs actively tied to GND via the low side drivers.

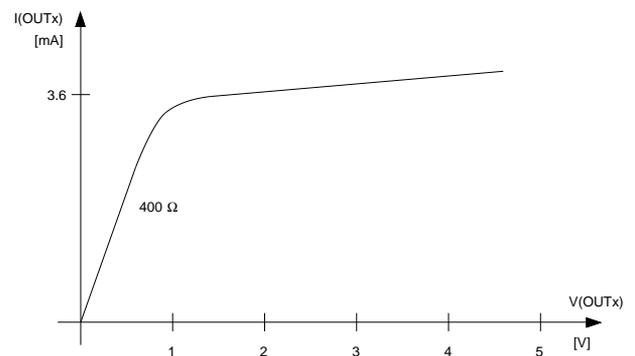


Figure 6: Output characteristics at OUTx with loss of VB, VBR or GNDR

### Loss of GND potential

If ground potential is not longer applied to GND, the output stages are shut down and the outputs tied to GNDR via current sources and internal pull-down resistors with a typical value of 200 k $\Omega$ .

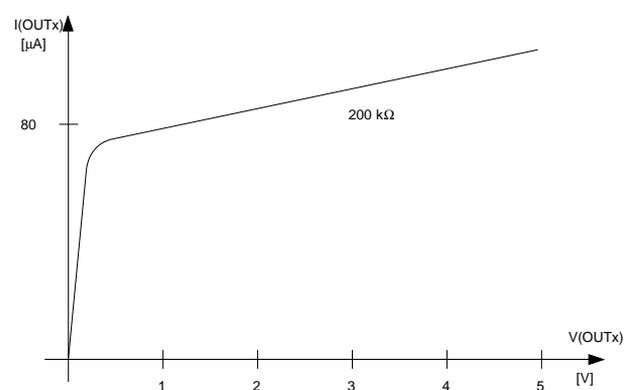


Figure 7: Output characteristics at OUTx with loss of GND

### APPLICATION NOTES

#### Driving an N-channel MOSFET

One typical field of application for iC-MFN is in the operation of N-FETs with microprocessor output signals, as shown in Figure 8.

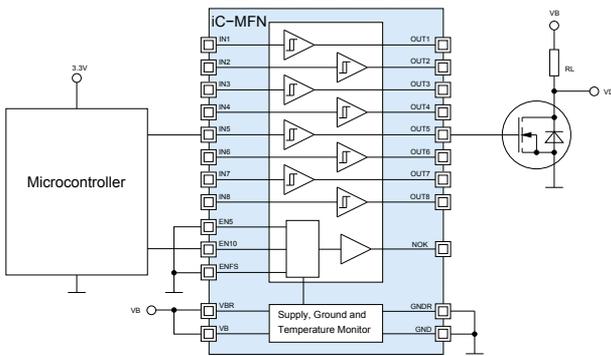


Figure 8: Driving an N-channel MOSFET

Slowly switching of a transistor is done with a current limited driver. Figure 9 shows the different phases of a turn on process with resistive load. In Section  $t_0$  to  $t_1$  the gate of the transistors is loaded to the threshold voltage  $V_{th}(FET)$  and is a dead time. In section  $t_1$  to  $t_2$  the gate voltage keeps nearly constant (miller-plateau) during the drain voltage slope. The slew rate depends on the current of the driver and the gate-drain capacitor of the transistor. In section  $t_2$  to  $t_3$  the gate voltage reach the static value. The transistor thus goes low ohmic and minimizes the power dissipation. The equations 1 to 4 are simplified and give an estimation of the timing on the basis of data from the specifications of the device iC-MFN and the used transistor. The turn off looks similar to the turn on but with reverse run trough.

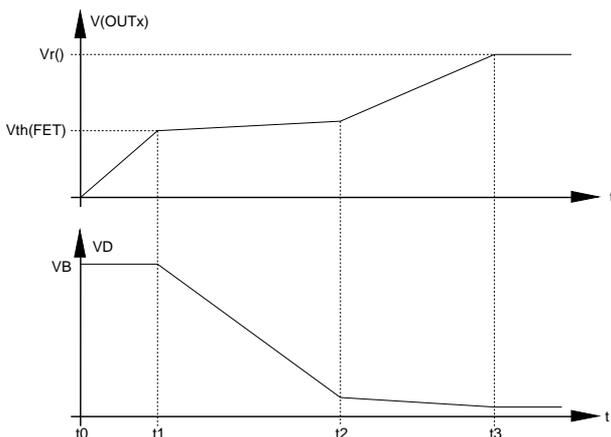


Figure 9: On switching of a transistor

$$t_{t0..t1}[\mu s] = C_{iss} @ (V_{ds} = hi) \times \frac{V_{th}(FET)}{-I_{sc}(OUTx)_{hi}} \quad (1)$$

$$t_{t1..t2}[\mu s] = C_{rss} @ (V_{ds} = hi) \times \frac{VB}{-I_{sc}(OUTx)_{hi}} \quad (2)$$

$$t_{t2..t3}[\mu s] = C_{iss} @ (V_{ds} = lo) \times \frac{V_r(OUTx) - V_{th}(FET)}{-I_{sc}(OUTx)_{hi}} \quad (3)$$

$$t_{on} = t_{t0..t1} + t_{t1..t2} + t_{t2..t3} \quad (4)$$

$C_{iss} = C_{gs} + C_{gd}$  = voltage dependent gate-source and gate-drain capacitor [nF]

$C_{rss} = C_{gd}$  = voltage dependent gate-drain capacitor [nF]

$I_{sc}(OUTx)_{lo}$  = short circuit current lo at OUTx [mA]

$t_{t0..t1}$  = dead time [ $\mu s$ ]

$t_{t1..t2}$  = slope time at drain (Miller-Plateau) [ $\mu s$ ]

$t_{t2..t3}$  = time to reach static gate voltage [ $\mu s$ ]

$t_{on}$  = overall turn on time [ $\mu s$ ]

$VB$  = power supply VB [V]

$V_r(OUTx)$  = configured static turn on voltage at OUTx [V]

$V_{th}(FET)$  = threshold of the transistor [V]

# iC-MFN

## 8-FOLD FAIL-SAFE N-FET DRIVER

### Example

Turn on calculation with following estimations:

$$C_{iss}@(V_{ds} = 24 \text{ V}) = 1.5 \text{ nF}$$

$$C_{iss}@(V_{ds} = 1 \text{ V}) = 3 \text{ nF}$$

$$C_{rss}@(V_{ds} = 24 \text{ V}) = 0.3 \text{ nF}$$

$$I_{sc}(OUTx)_{hi} = -4 \text{ mA}$$

$$V_B = 24 \text{ V}$$

$$V_r(OUTx) = 10 \text{ V}$$

$$V_{th}(FET) = 3 \text{ V}$$

From this follows:

$$t_{t0..t1} = 1.13 \mu\text{s}$$

$$t_{t1..t2} = 1.8 \mu\text{s}$$

$$t_{t2..t3} = 5.25 \mu\text{s}$$

$$t_{on} = 8.18 \mu\text{s}$$

The slew rate at the drain of transistor is: 13.3 V/ $\mu$ s

Figure 10 shows the turn on and off at one channel with pin INx. The pulse duration at pin NOK, especially at turn on, can be used for monitoring the connected transistor and the load.

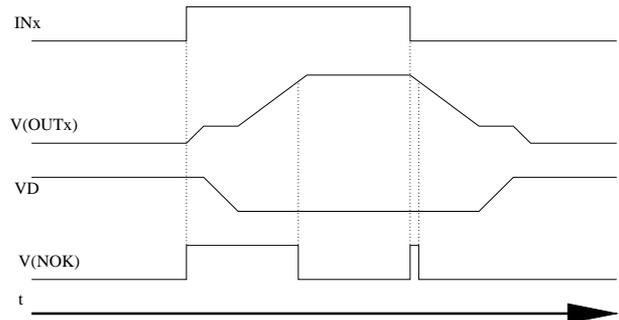


Figure 10: Turn on and off one channel with INx

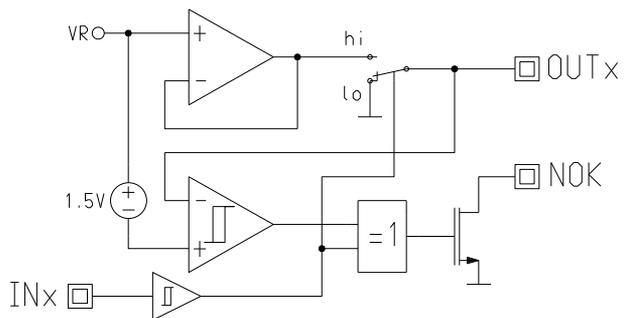


Figure 11: Circuit diagram one channel with monitoring comparator

### REVISION HISTORY

Rel.	Rel. Date*	Chapter	Modification	Page
A1	2006-07-19		Initial Release	
A2	2007-06-25	ELECTRICAL CHARACTERISTICS	Changes A1 A2	4
B1	2018-07-06	ELECTRICAL CHARACTERISTICS	Items 101, 102, 201, 202, 407, 408, 501, 502, 607, 608 removed due to exceeding the ABSOLUTE MAXIMUM RATINGS	5, 6
		ELECTRICAL CHARACTERISTICS	Items 006, 008, 105, 106, 107, 209, 301, 302 updated	5, 6
		ELECTRICAL CHARACTERISTICS	Test mode removed	6
		REVISION HISTORY	Chapter added	12

\* Release Date format: YYYY-MM-DD

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preliminary



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## ORDERING INFORMATION

Type	Package	Order Designation
iC-MFN	QFN24 4 mm x 4 mm	iC-MFN QFN24
Evaluation Board	Board 80 mm x 100 mm	iC-MFN EVAL MFN1D

Please send your purchase orders to our order handling team:

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For technical support, information about prices and terms of delivery please contact:

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